

**Search Notes**

Application No.

10/657,639

Examiner

Christopher M. Keehan

**Applicant(s)**

LAI ET AL.

Art Unit

1712

**SEARCHED**

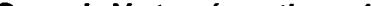
Class	Subclass	Date	Examiner
556	425	2/2/2005	CMK
	443		
	450		
	453		
528	28		
106	31.51		
	31.52		
525	100		
	106		
351	156		
	160R		
	162		
264	1.1		
623	6.11		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/2/2005	CMK
STN search		
Inventor name search		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as	above	2/2/2005	CMK

Search Notes (continued)	Application No.	Applicant(s)
	10/657,639	LAI ET AL.
Examiner	Art Unit	
Christopher M. Keehan	1712	

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
<b>same as</b>	<b>above</b>	<b>2/2/2005</b>	<b>CMK</b>